


Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/518,367	SHIGA ET AL.	
		Examiner	Art Unit	
		Tran N. Nguyen	2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	43	4/24/05	TNN
	216		
	217		
	156.08		
	156.15		
	156.28		
	156.29		
	156.53		
	156.56		
	156.38		
	156.39		
update 9/13/06 TNN			
update all 11/28/06 TNN			
above			
360	97.1-99.12	11/28/06	TNN
update all 3/27/07 TNN			
above			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
310	all above	9/13/06	TNN
310	all	3/27/07	TNN
360	above	11/07	TNN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Interference Search	9/13/06	TNN
Interference Search	3/27/07	TNN